

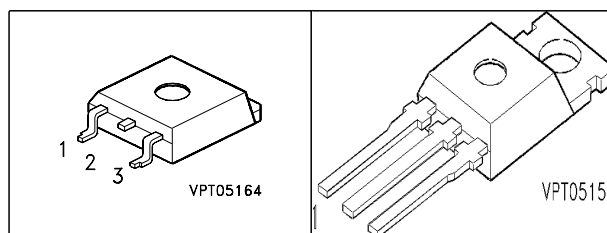
## SIPMOS® Power-Transistor

### Features

- P-Channel
- Enhancement mode
- Avalanche rated
- $dv/dt$  rated
- 175°C operating temperature

### Product Summary

Drain source voltage	$V_{DS}$	-60	V
Drain-source on-state resistance	$R_{DS(on)}$	0.13	$\Omega$
Continuous drain current	$I_D$	-18.6	A



Type	Package	Ordering Code
SPP18P06P	P-TO220-3-1	Q67040-S4182
SPB18P06P	P-TO263-3-2	Q67040-S4191

Pin 1	PIN 2/4	PIN 3
G	D	S

**Maximum Ratings**, at  $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_C = 25\text{ °C}$ $T_C = 100\text{ °C}$	$I_D$	-18.6 -13.2	A
Pulsed drain current $T_C = 25\text{ °C}$	$I_{D\text{ puls}}$	-74.4	
Avalanche energy, single pulse $I_D = -18.6\text{ A}$ , $V_{DD} = -25\text{ V}$ , $R_{GS} = 25\text{ }\Omega$	$E_{AS}$	150	mJ
Avalanche energy, periodic limited by $T_{j\text{max}}$	$E_{AR}$	8	
Reverse diode $dv/dt$ $I_S = -18.6\text{ A}$ , $V_{DS} = -48\text{ V}$ , $di/dt = 200\text{ A}/\mu\text{s}$ , $T_{j\text{max}} = 175\text{ °C}$	$dv/dt$	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_C = 25\text{ °C}$	$P_{\text{tot}}$	80	W
Operating and storage temperature	$T_j$ , $T_{\text{stg}}$	-55...+175	°C
IEC climatic category; DIN IEC 68-1		55/175/56	

### Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	$R_{thJC}$	-	-	1.85	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$	-	-	62	
SMD version, device on PCB:	$R_{thJA}$				
@ min. footprint		-	-	62	
@ 6 cm <sup>2</sup> cooling area 1)		-	-	40	

### Electrical Characteristics, at $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain- source breakdown voltage $V_{GS} = 0\text{ V}$ , $I_D = -250\text{ }\mu\text{A}$	$V_{(BR)DSS}$	-60	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = -1\text{ mA}$	$V_{GS(th)}$	-2.1	-3	-4	
Zero gate voltage drain current $V_{DS} = -60\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25\text{ }^{\circ}\text{C}$ $V_{DS} = -60\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 150\text{ }^{\circ}\text{C}$	$I_{DSS}$	-	-0.1 -10	-1 -100	$\mu\text{A}$
Gate-source leakage current $V_{GS} = -20\text{ V}$ , $V_{DS} = 0\text{ V}$	$I_{GSS}$	-	-10	-100	
Drain-source on-state resistance $V_{GS} = -10\text{ V}$ , $I_D = -13.2\text{ A}$	$R_{DS(on)}$	-	0.1	0.13	$\Omega$

<sup>1</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70  $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

**Electrical Characteristics, at  $T_j = 25\text{ °C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Dynamic Characteristics**

Transconductance $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ , $I_D = -13.2\text{ A}$	$g_{fs}$	4	8	-	S
Input capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = -25\text{ V}$ , $f = 1\text{ MHz}$	$C_{iss}$	-	690	860	pF
Output capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = -25\text{ V}$ , $f = 1\text{ MHz}$	$C_{oss}$	-	230	290	
Reverse transfer capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = -25\text{ V}$ , $f = 1\text{ MHz}$	$C_{rss}$	-	95	120	
Turn-on delay time $V_{DD} = -30\text{ V}$ , $V_{GS} = -10\text{ V}$ , $I_D = -13.2\text{ A}$ , $R_G = 2.7\text{ }\Omega$	$t_{d(on)}$	-	12	18	ns
Rise time $V_{DD} = -30\text{ V}$ , $V_{GS} = -10\text{ V}$ , $I_D = -13.2\text{ A}$ , $R_G = 2.7\text{ }\Omega$	$t_r$	-	5.8	8.7	
Turn-off delay time $V_{DD} = -30\text{ V}$ , $V_{GS} = -10\text{ V}$ , $I_D = -13.2\text{ A}$ , $R_G = 2.7\text{ }\Omega$	$t_{d(off)}$	-	24.5	37	
Fall time $V_{DD} = -30\text{ V}$ , $V_{GS} = -10\text{ V}$ , $I_D = -13.2\text{ A}$ , $R_G = 2.7\text{ }\Omega$	$t_f$	-	11	16.5	

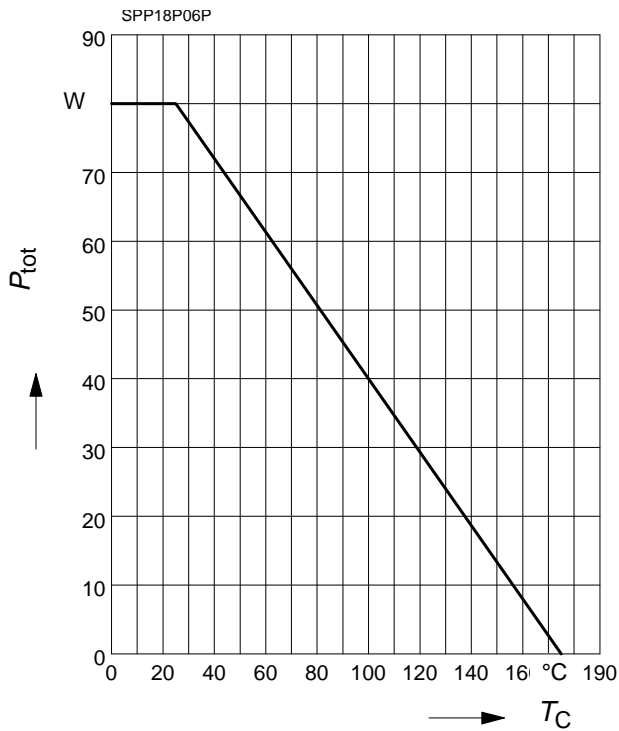
**Electrical Characteristics, at  $T_j = 25\text{ °C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Dynamic Characteristics					
Gate to source charge $V_{DD} = -48$ , $I_D = -18.6$ A	$Q_{gs}$	-	4.4	6.6	nC
Gate to drain charge $V_{DD} = -48$ V, $I_D = -18.6$ A	$Q_{gd}$	-	9.3	14	
Gate charge total $V_{DD} = -48$ V, $I_D = -18.6$ , $V_{GS} = 0$ to $-10$ V	$Q_g$	-	22	33	
Gate plateau voltage $V_{DD} = -48$ , $I_D = -18.6$ A	$V_{(plateau)}$	-	-5.56	-	V

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Reverse Diode					
Inverse diode continuous forward current $T_C = 25\text{ }^{\circ}\text{C}$	$I_S$	-	-	-18.6	A
Inverse diode direct current,pulsed $T_C = 25\text{ }^{\circ}\text{C}$	$I_{SM}$	-	-	-74.4	
Inverse diode forward voltage $V_{GS} = 0\text{ V}$ , $I_F = -18.6\text{ A}$	$V_{SD}$	-	-1	-1.33	V
Reverse recovery time $V_R = -30\text{ V}$ , $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$	$t_{rr}$	-	70	105	ns
Reverse recovery charge $V_R = -30\text{ V}$ , $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$	$Q_{rr}$	-	139	208	nC

### Power dissipation

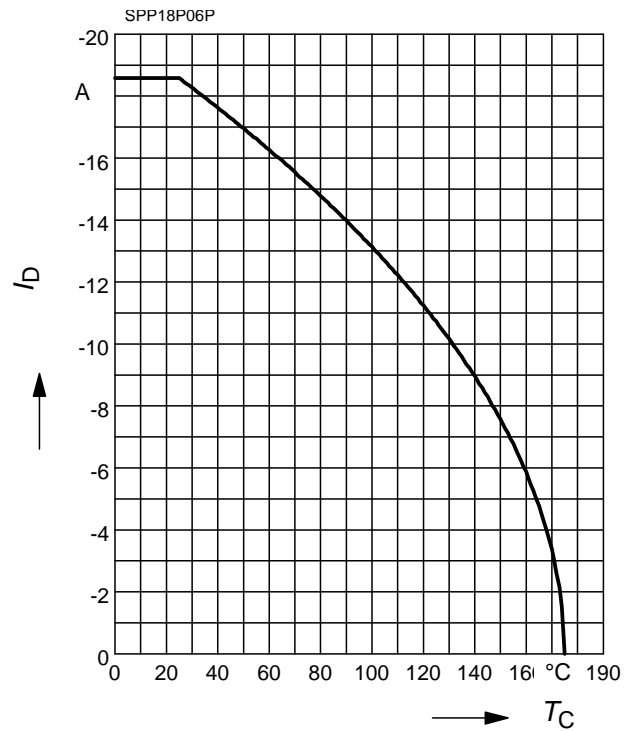
$$P_{\text{tot}} = f(T_C)$$



### Drain current

$$I_D = f(T_C)$$

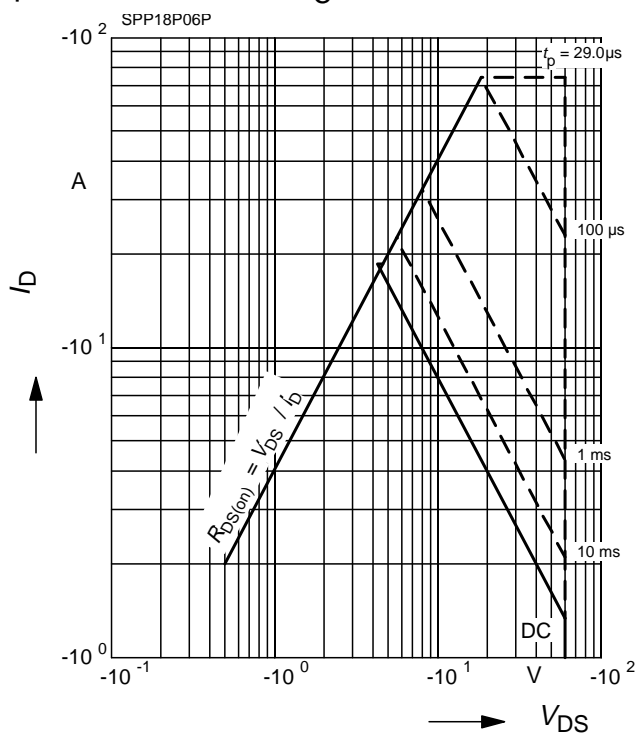
parameter:  $V_{GS} \geq 10 \text{ V}$



### Safe operating area

$$I_D = f(V_{DS})$$

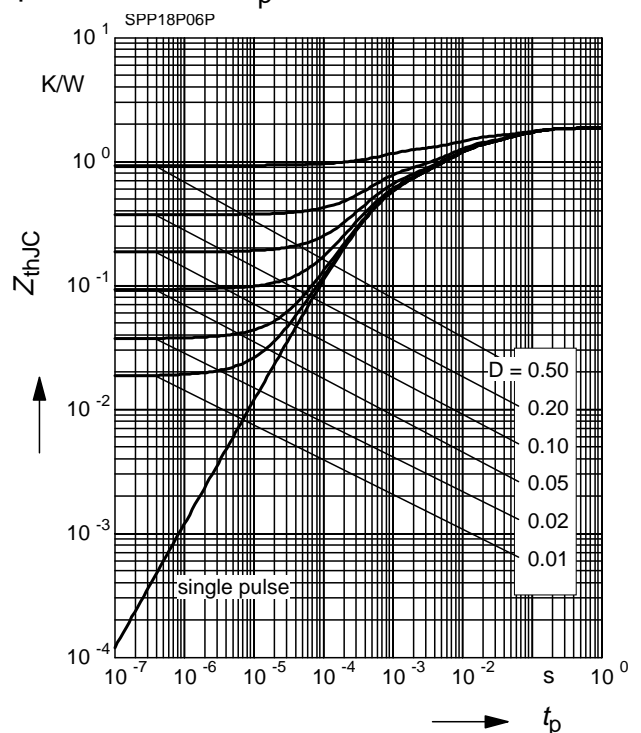
parameter:  $D = 0$ ,  $T_C = 25^\circ\text{C}$



### Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

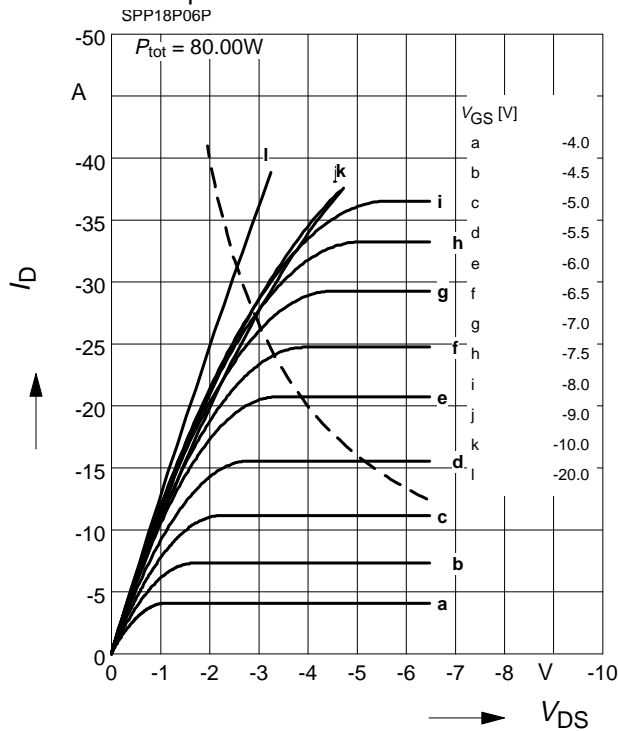
parameter:  $D = t_p/T$



### Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

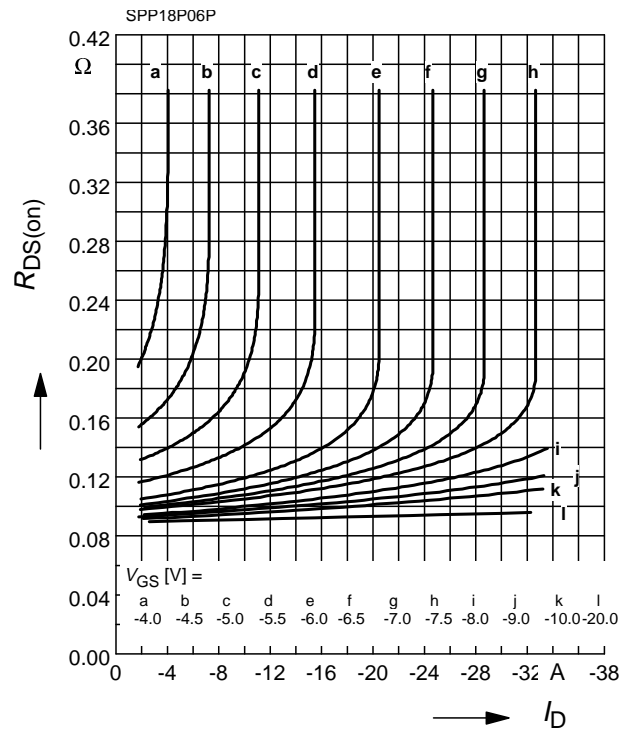
parameter:  $t_p = 80 \mu\text{s}$



### Typ. drain-source-on-resistance

$$R_{DS(\text{on})} = f(I_D)$$

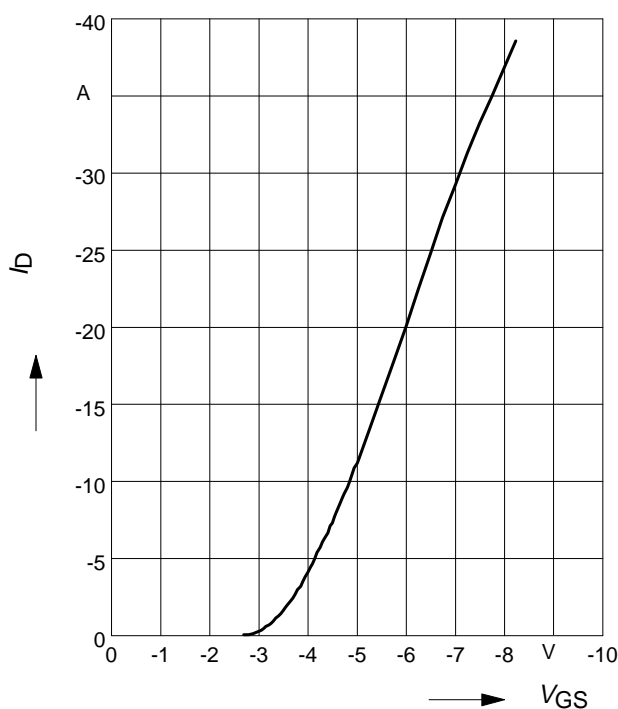
parameter:  $V_{GS}$



### Typ. transfer characteristics $I_D = f(V_{GS})$

$$V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}$$

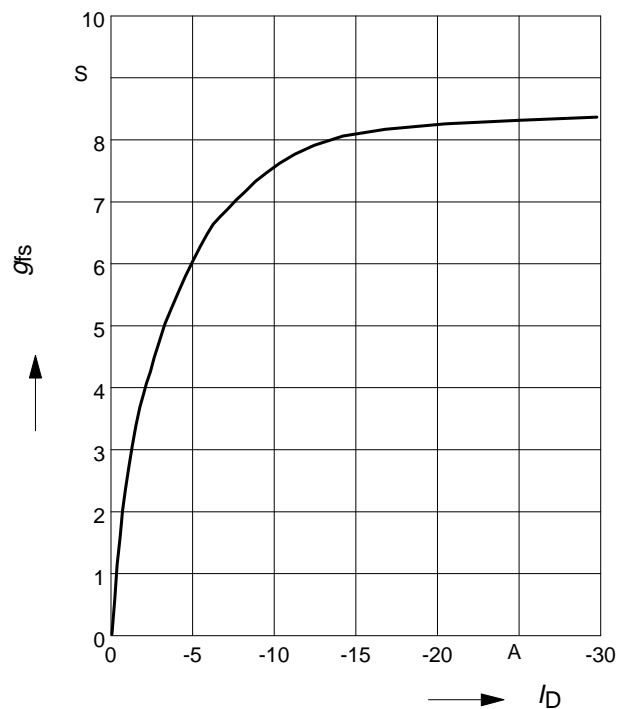
parameter:  $t_p = 80 \mu\text{s}$



### Typ. forward transconductance

$$g_{fs} = f(I_D); T_j = 25^\circ\text{C}$$

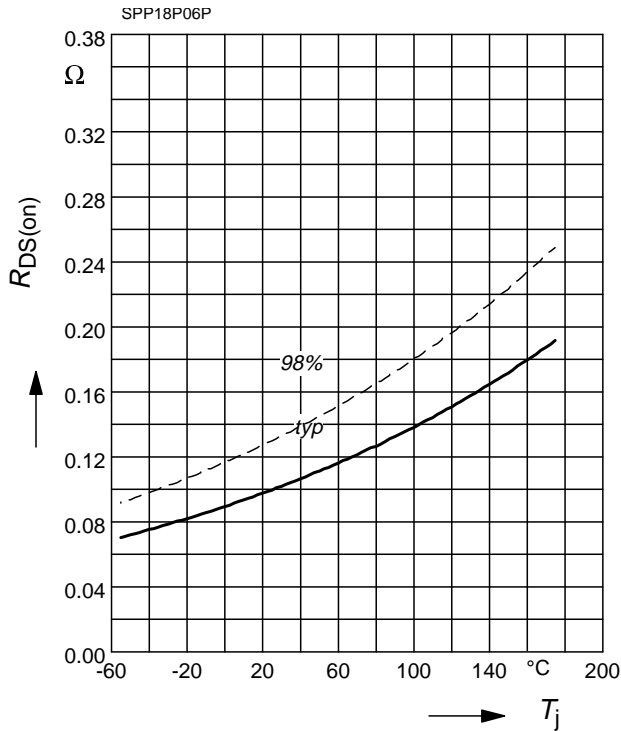
parameter:  $g_{fs}$



### Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

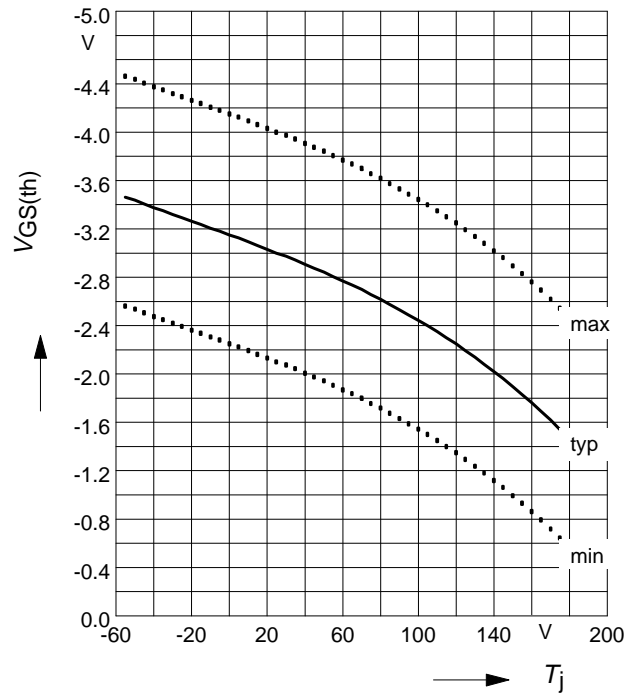
parameter:  $I_D = -13.2 \text{ A}$ ,  $V_{GS} = -10 \text{ V}$



### Gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

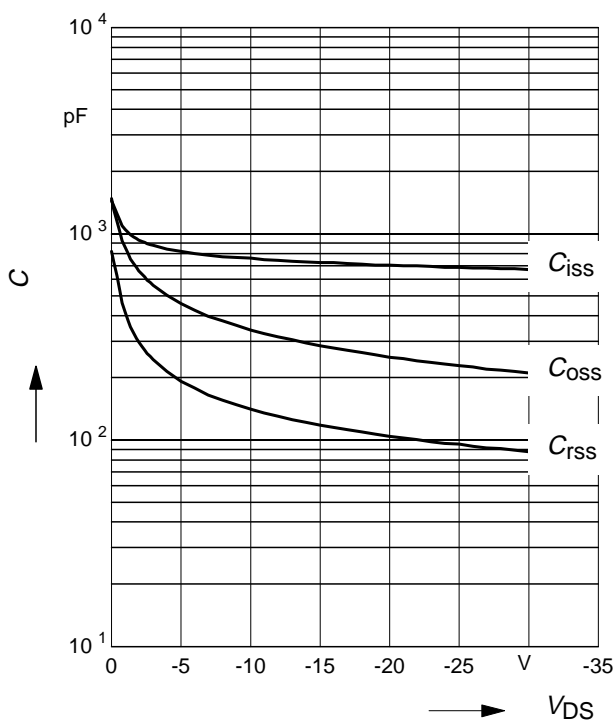
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = -1 \text{ mA}$



### Typ. capacitances

$$C = f(V_{DS})$$

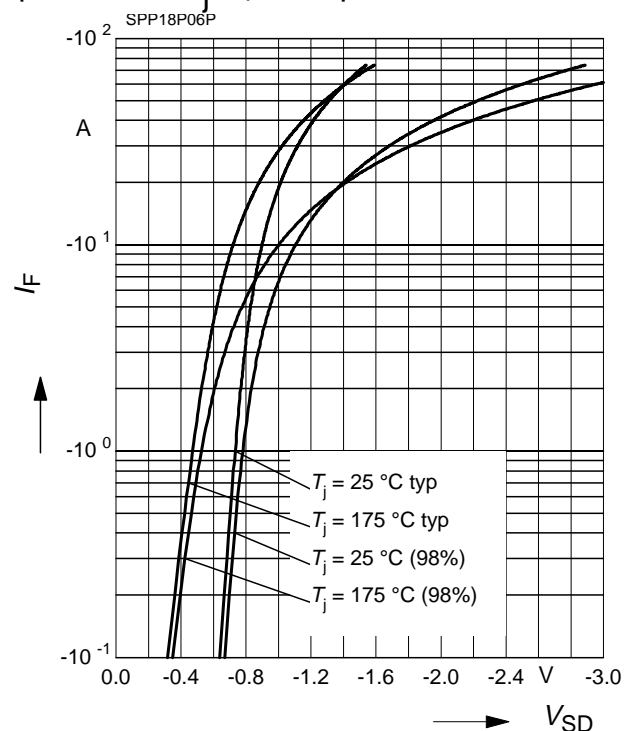
parameter:  $V_{GS} = 0 \text{ V}$ ,  $f = 1 \text{ MHz}$



### Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

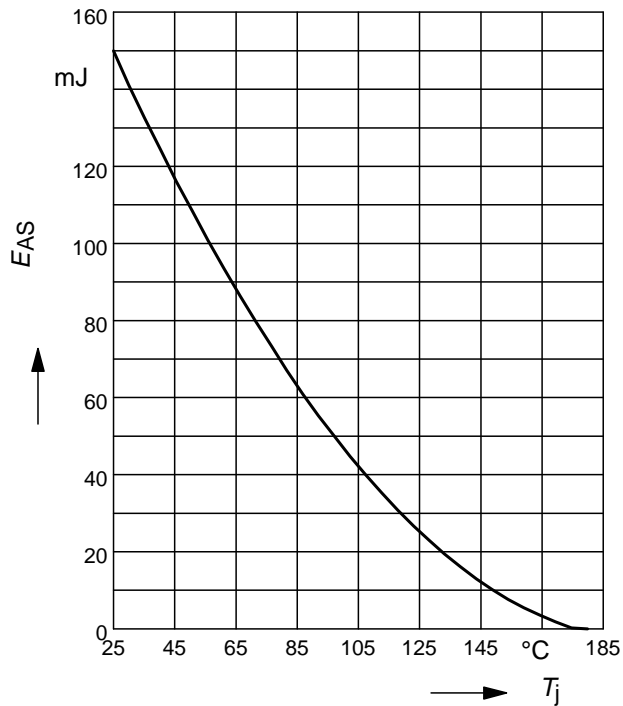
parameter:  $T_j$ ,  $t_p = 80 \mu\text{s}$



### Avalanche energy

$$E_{AS} = f(T_j)$$

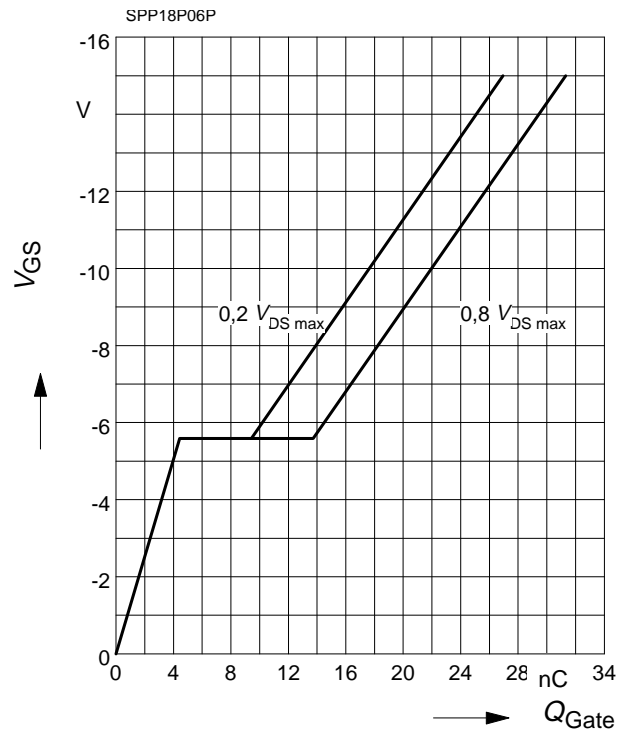
para.:  $I_D = -18.6 \text{ A}$  ,  $V_{DD} = -25 \text{ V}$  ,  $R_{GS} = 25$



### Typ. gate charge

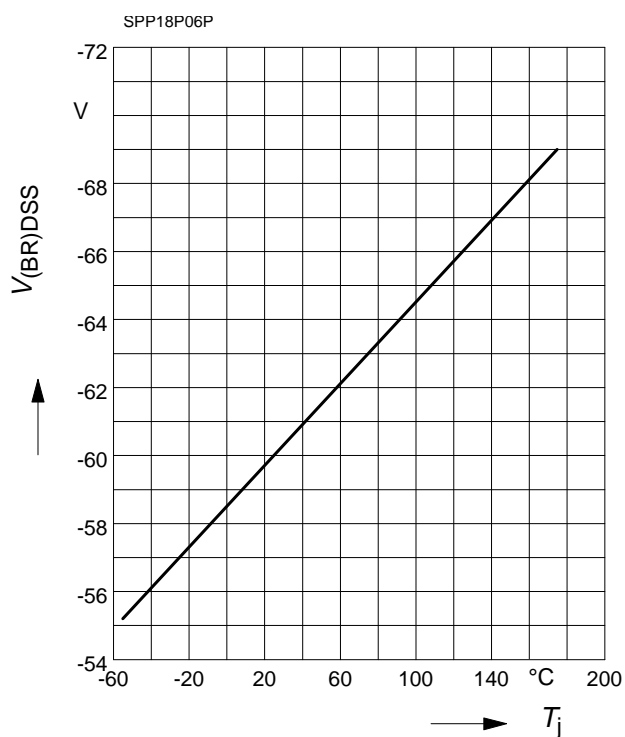
$$V_{GS} = f(Q_{Gate})$$

parameter:  $I_D = -18.6 \text{ A}$  pulsed



### Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$





**Published by**  
**Infineon Technologies AG,**  
**Bereichs Kommunikation**  
**St.-Martin-Strasse 53,**  
**D-81541 München**  
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